

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 09/933,692 | Applicant(s)/Patent Under Reexamination EMA, NOBUAKI | |
| | Examiner sang nguyen | Art Unit 2877 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,687,008 | 02-2004 | Peale et al. | 356/477 |
| | B | US-6,614,511 | 09-2003 | Sakairi et al. | 356/73.1 |
| | C | US-6,559,946 | 05-2003 | Davidson et al. | 356/450 |
| | D | US-6,493,074 | 12-2002 | Imamura et al. | 356/124.5 |
| | E | US-6,061,124 | 05-2000 | Nyman et al. | 356/124 |
| | F | US-5,844,235 | 12-1998 | Tachikawa et al. | 250/227.14 |
| | G | US-5,227,623 | 07-1993 | Heffner, Brian L. | 250/225 |
| | H | US-4,545,253 | 10-1985 | Avicola, Kenneth | 73/655 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.